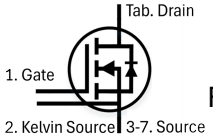
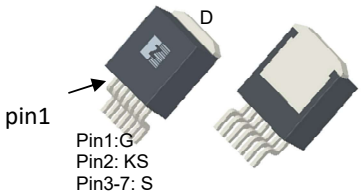
General Description

This silicon carbide Power MOSFET device has been developed using ZMJ's advanced 1st generation SiC MOSFET technology. The device features a very low $R_{DS(on)}$ over the entire temperature range combined with low capacitances and very high switching operations. It improves application performance in frequency, energy efficiency, system size and weight reduction.

Product Summary



V_{DS}= 3300V
$R_{DS(ON)}$ = 640mΩ
I_D= 6A



TO-263-7

Features

- High Blocking Voltage
- High Speed Switching With Low Capacitances
- Low $R_{DS(ON)}$ to Minimize Conductive Loss
- Low Gate Charge For Fast Switching
- Low Thermal Resistance
- 100% Avalanche Tested

Application

- Motor Drives
- DC-DC
- Switched Mode Power Supply
- Auxiliary Power Supply

Ordering Information:

Part NO.	ZMC100KR330B7
Marking	ZMC100KR330
Packing Information	REEL TAPE
Basic Ordering Unit (pcs)	800

Absolute Maximum Ratings (T_C=25°C)

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	V_{DS}		3300	V
Gate-Source Voltage	V_{GS}	Transient Voltage	-10V/25V	V
	V_{GS}	Static Voltage	-10V/20V	V
Recommended Turn On Gate Voltage	$V_{GS(on)}$		18 to 20V	V
Recommended Turn Off Gate Voltage	$V_{GS(off)}$		-5V to 0V	V
Continuous Drain Current	I_D	V_{GS}=20V,T_C=25°C	6	A
	I_D	V_{GS}=20V,T_C=75°C	5	A
	I_D	V_{GS}=20V,T_C=100°C	4	A

Pulsed Drain Current ①	I_{DM}	Pulsed; $t_p \leq 10$ μs; $T_{mb} = 25$ °C;	24	A
Total Power Dissipation	P_D	T_C=25℃	75	W
Total Power Dissipation	P_D	T_A=25℃	2.4	W
Operating Junction Temperature	T_J		-55 to +175	℃
Storage Temperature	T_{STG}		-55 to +175	℃
ESD Level (HBM)			Class2	

• Thermal Resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance, Junction - Case	R_{thJC}	-	-	2	°C/W
Thermal Resistance, Junction-Ambient	R_{thJA}①	-	-	62	°C/W
Soldering Temperature(total time<10s)	Tsold	-	-	260	°C

• Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	V_{GS} =0V, I_D =100uA	3300	-	-	V
Gate Threshold Voltage	$V_{GS(TH)}$	V_{GS} =V_{DS}, I_D =2mA	3	4.4	5	V
		V_{GS} =V_{DS}, I_D =2mA,T_j=175°C	-	3.2	-	
Drain-Source Leakage Current	I_{DSS}	V_{GS}=0V,V_{DS}=3300V	-	-	10	uA
Gate- Source Leakage Current	I_{GSS}	V_{GS}=-10V, V_{DS} =0V	-	-	-100	nA
		V_{GS}=25V, V_{DS} =0V	-	-	100	nA
Static Drain-Source On Resistance	$R_{DS(on)}$	T_j=25°C,V_{GS}=20V,I_D=2A	-	640	800	mΩ
		T_j=175°C,V_{GS}=20V,I_D=2A	-	1800	-	mΩ
		T_j=25°C,V_{GS}=18V,I_D=2A	-	690	-	mΩ
Forward Transconductance	g_{fs}	V_{DS} =10V,I_{SD} =2A	-	1	-	S
Diode Forward Voltage	V_{FSD}	V_{GS} =-5V, I_{SD} =2A	-	3.9	5	V

• Dynamic Characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input Capacitance	C_{iss}	f = 100KHz, V_{DS}=1000V	-	415	-	pF
Output Capacitance	C_{oss}		-	11	-	
Reverse Transfer Capacitance	C_{rss}		-	1.8	-	
Output Charge	Q_{oss}	f = 100KHz,V_{GS}=0V, V_{DS}=0V to 1000V	-	26.4	-	nC
Coss Stored Energy	E_{oss}		-	9.5	-	uJ
Gate Risistance	R_g	f = 1MHz	-	4.8	-	Ω
Total Gate Charge	Q_g	V_{DD} = 1000V, I_D = 2A, V_{GS} = -5V/20V	-	24	-	nC
Gate - Source Charge	Q_{gs}		-	6	-	
Gate - Drain Charge	Q_{gd}		-	14	-	

Characteristics Diagrams

Fig.1 Gate-Charge Characteristics

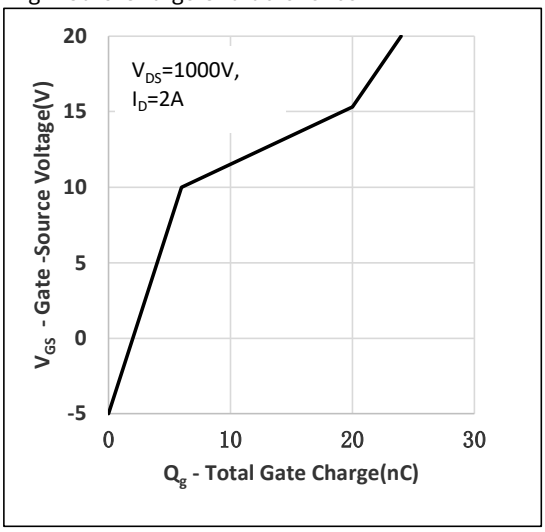


Fig.2 Capacitance Characteristics

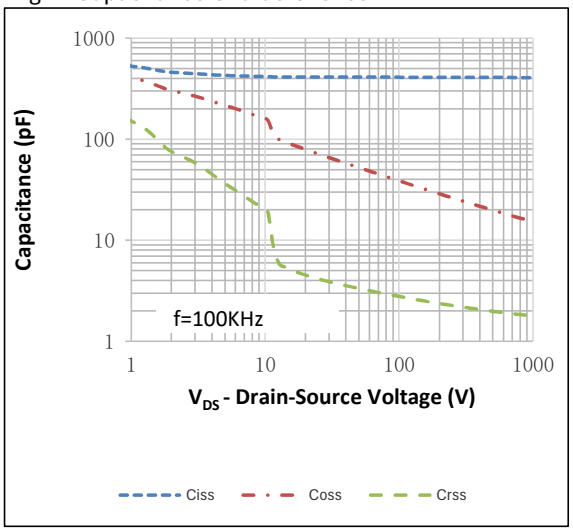


Fig.3 Power Dissipation

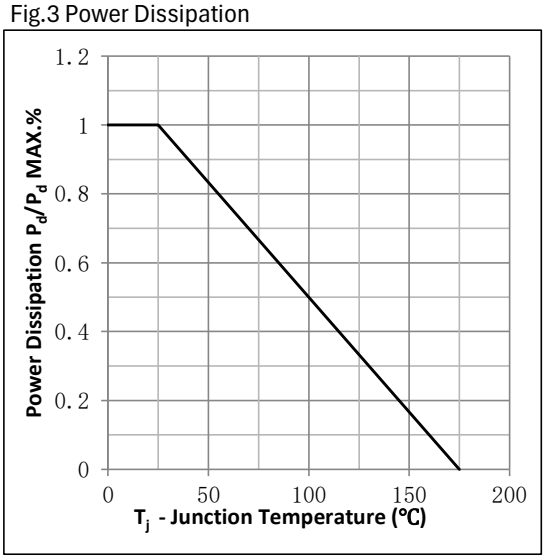


Fig.4 Typical Output Characteristics

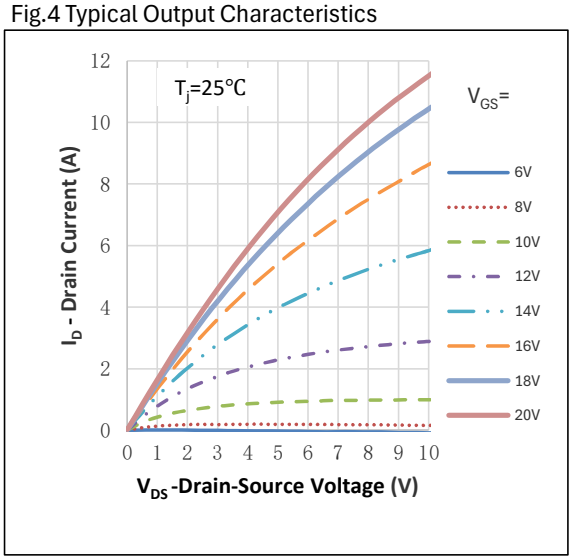


Fig.5 Threshold Voltage vs. Junction Temperature

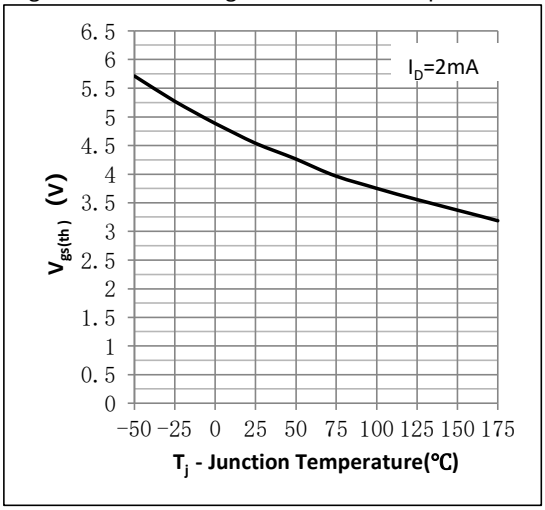


Fig.6 On-Resistance vs. Drain Current

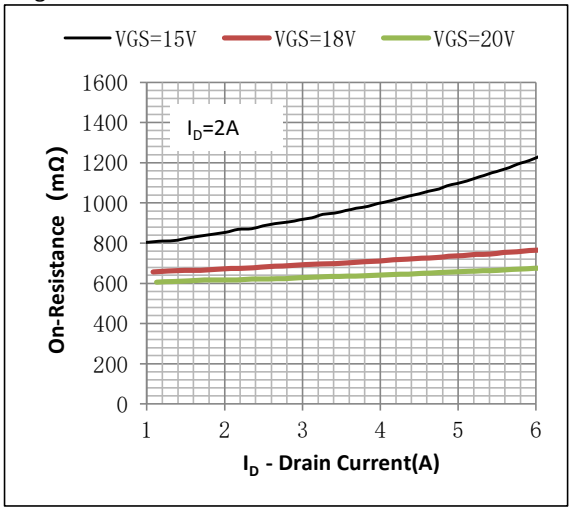


Fig.7 On-Resistance vs. Gate Source Voltage

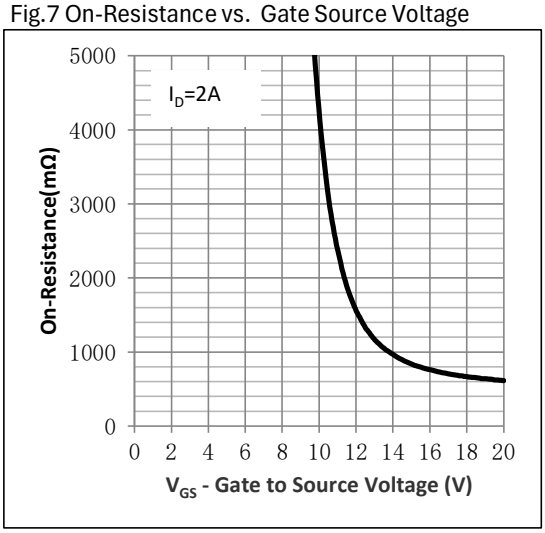


Fig.8 On-Resistance vs. Junction Temperature

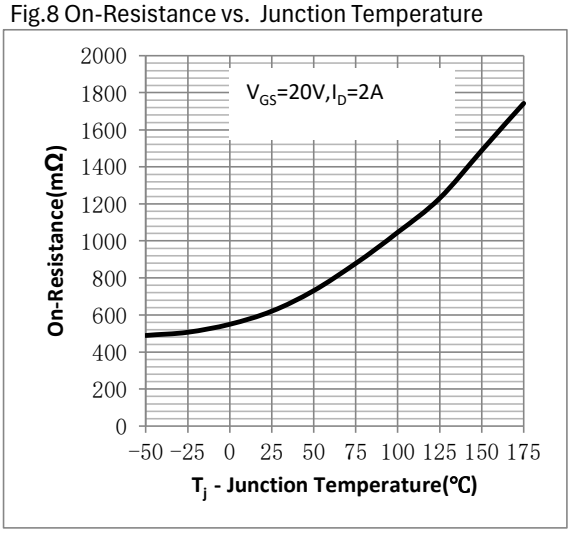


Figure 9. Diode Forward Voltage vs. Current

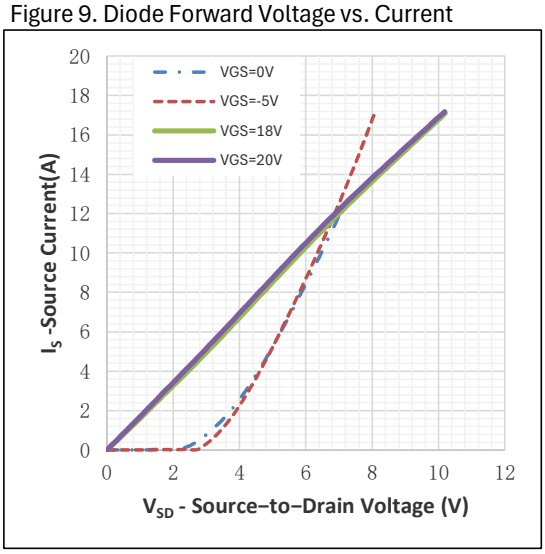


Figure 10. Transfer Characteristics

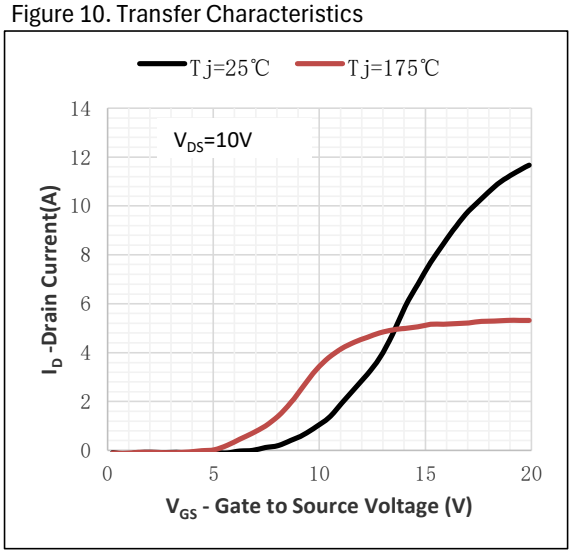


Fig.11 SOA Maximum Safe Operating Area

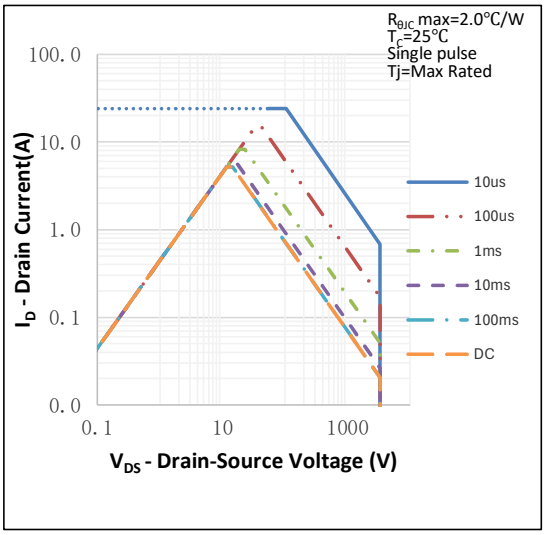


Fig.12 I_D vs. Junction Temperature②

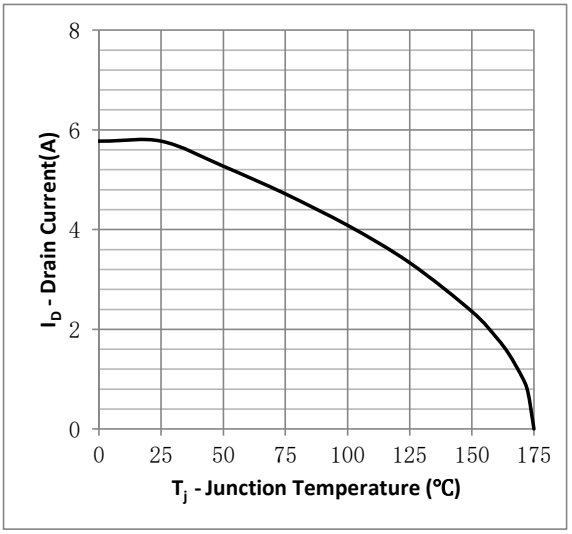


Fig.13 Output Capacitor Stored Energy

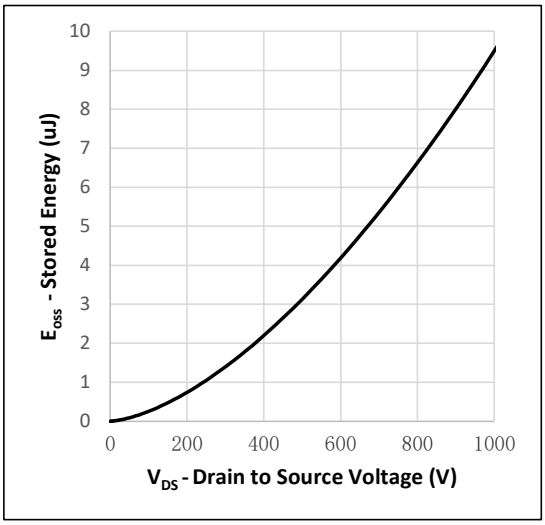
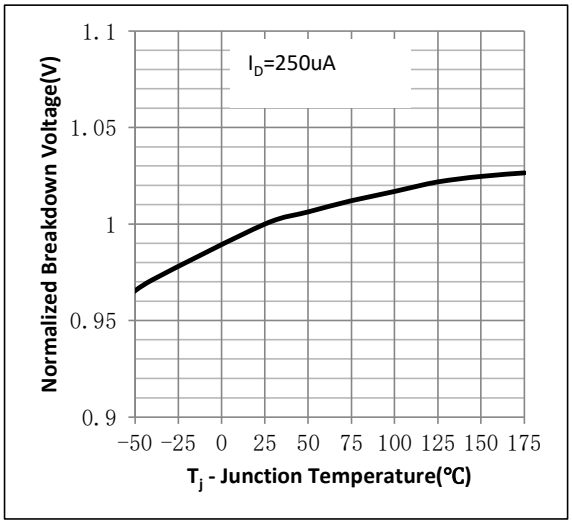
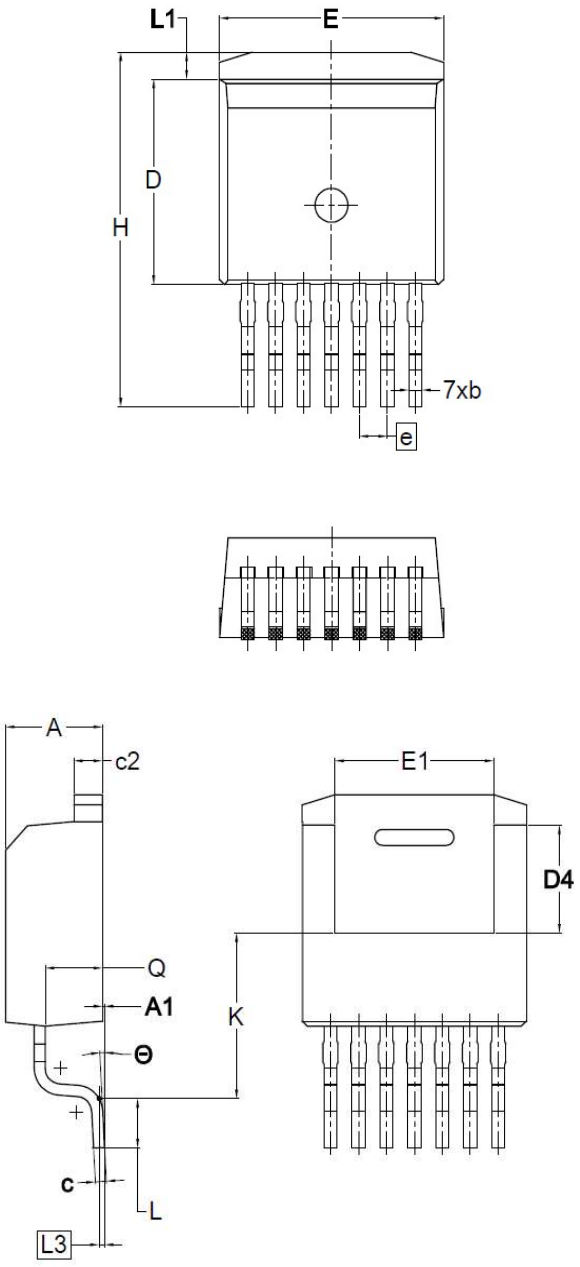


Fig.14 Normalized Breakdown Voltage vs. Junction Temperature



●TO-263-7 Package Outline



SYMBOL	DIMENSIONS		
	MIN.	NOM.	MAX.
A	4.30	4.40	4.50
A1	0.00	0.10	0.25
b	0.50	0.60	0.70
c	0.45	0.50	0.60
c2	1.20	1.30	1.40
D	8.93	9.08	9.23
D4	4.65	4.80	4.95
E	10.08	10.18	10.28
E1	6.82	7.22	7.62
e	1.27 BSC		
H	15.00	15.70	16.00
K	7.30		
L	1.90	2.20	2.50
L1	1.00	1.20	1.40
L3	0.25 BSC		
Q	2.45	2.60	2.75
Θ	0°	3°	7°

Note:

① The value of RθJA is measured with the device in a still environment with TA=25°C

②Practically the current will be limited by PCB, thermal design and operating temperature. V_{GS}=18V.

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Revision History:

Version	Date	Change
A	2024/11/20	New